Silicon Carbide Schottky Diode

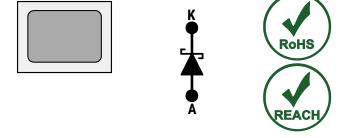


| VRRM = | 1700 V |
|------------------|--------|
| F (Tc = 127°C) = | 75 A |
| Qc = | 524 nC |

Features

- Gen4 Thin Chip Technology for Low V_{F}
- Enhanced Surge and Avalanche Robustness
- Superior Figure of Merit Q_C/I_F
- Low Thermal Resistance
- Low Reverse Leakage Current
- Temperature Independent Fast Switching
- Positive Temperature Coefficient of V_F
- Low V_F for High Temperature Operation

Bare Chip



Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Improved System Efficiency

Applications

- EV Fast Chargers
- Solar Inverters
- Wind Energy Converters
- Train Auxiliary Power Supplies
- High Frequency Rectifiers
- Switched Mode Power Supplies
- Motor Drives
- Pulsed Power

Absolute Maximum Ratings (At T_c = 25°C Unless Otherwise Stated)

| Parameter | Symbol | Conditions | Values | Unit | Note |
|---|-----------------------------------|---|------------|------------------|------|
| Repetitive Peak Reverse Voltage | V _{RRM} | | 1700 | V | |
| | | T _C = 100°C, D = 1 | 97 | | |
| Continuous Forward Current | IF | T _C = 135°C, D = 1 | 67 | А | |
| | | T _C = 127°C, D = 1 | 75 | | |
| Non-Repetitive Peak Forward Surge Current, Half Sine | Irou | T _C = 25°C, t _P = 10 ms | 750 | А | |
| Wave | I _{F,SM} | Tc = 150°C, t⊵ = 10 ms | 600 | | |
| Repetitive Peak Forward Surge Current, Half Sine Wave | lenu | T _C = 25°C, t _P = 10 ms | 450 | А | |
| | I _{F,RM} | Tc = 150°C, t⊵ = 10 ms | 315 | | |
| Non-Repetitive Peak Forward Surge Current | I _{F,MAX} | T _C = 25°C, t _P = 10 μs | 3750 | А | |
| i ² t Value | ∫i²dt | T _C = 25°C, t _P = 10 ms | 2812 | A ² s | |
| Non-Repetitive Avalanche Energy | E _{AS} | L = 0.5 mH, I _{AS} = 75 A | 1270 | mJ | |
| Diode Ruggedness | dV/dt | V _R = 0 ~ 1360 V | 200 | V/ns | |
| Power Dissipation | Ртот | T _C = 25°C | 556 | W | |
| Operating and Storage Temperature | T _j , T _{stg} | | -55 to 175 | °C | |

*Assumes Thermal Resistance, Junction - Case (RthJC) of 0.27°C/W



Electrical Characteristics

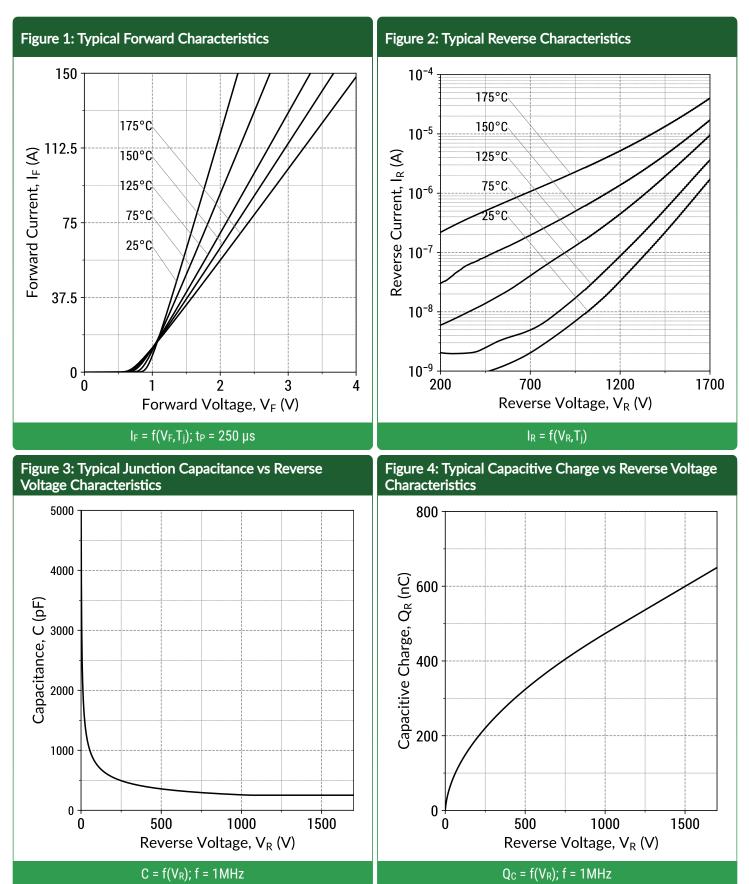
| Parameter | Symbol | Conditions | | Values | | 11-14 | Note | |
|-------------------------|----------------|---|-------------------------|--------|------|-------------|------|---------------|
| Parameter | Symbol | | | Min. | Тур. | Max. | Unit | Note |
| Diada Farward Valtaga | V _F | I _F = 75 A, T _j | i = 25°C | | 1.6 | 1.8 V Fig 1 | | |
| Diode Forward Voltage | VF | I _F = 75 A, T _j = 175°C | | | 2.4 | | v | Fig. 1 |
| Reverse Current | l- | V _R = 1700 V, T _j = 25°C | | | 2 | 10 | | Fig. 2 |
| | I _R | V _R = 1700 V, T _j = 175°C | | | 41 | | μA | |
| Total Capacitive Charge | 0 | | V _R = 600 V | | 358 | | nC | Fig. 4 |
| | Qc | I _F ≤ I _{F.MAX} | V _R = 1200 V | | 524 | | | |
| | | • | V _R = 600 V | | . 10 | | | |
| Switching Time | ts | | V _R = 1200 V | | < 10 | 10 | ns | |
| Tatal Canaditanaa | 0 | V _R = 1 V, f = | = 1MHz | | 4577 | | | Fig. 0 |
| Total Capacitance | С | V _R = 1200 V, f = 1MHz | | | 252 | | pF | Fig. 3 |

Mechanical Parameters

This information is confidential, please contact sales@genesicsemi.com to learn more.

GD75MPS17-CAL 1700V 75A SiC Schottky MPS[™] Diode





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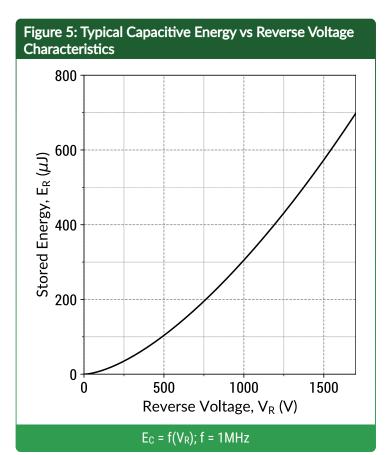
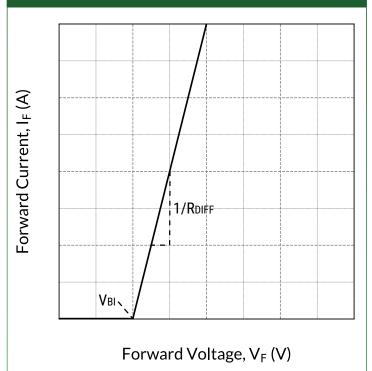


Figure 6: Forward Curve Model



$I_F = f(V_F,T_j)$



Forward Curve Model Equation:

 $I_F = (V_F - V_{BI})/R_{DIFF} (A)$

Built-In Voltage (V_{BI}):

 $V_{BI}(T_j) = m \times T_j + n (V)$ m = -0.00125 (V/°C) n = 1.0 (V)

Differential Resistance (RDIFF):

 $R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c (\Omega)$ a = 1.61e-07 (\Omega/°C^2) b = 5.53e-05 (\Omega/°C) c = 7.14e-03 (\Omega)

Forward Power Loss Equation:

 $P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$



Chip Dimensions

This information is confidential, please contact sales@genesicsemi.com to learn more.

NOTE

1. CONTROLLED DIMENSION IS MILLIMETER.

2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.



Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

| SPICE Models: | https://www.genesicsemi.com/sic-schottky-mps/GD75MPS17-CAL/GD75MPS17-CAL_SPICE.zip |
|----------------------------------|--|
| PLECS Models: | https://www.genesicsemi.com/sic-schottky-mps/GD75MPS17-CAL/GD75MPS17-CAL_PLECS.zip |
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| • Quality Manual: | https://www.genesicsemi.com/quality |
| | |

| Revision History | | | | | | | |
|------------------|----------|-----------------|------------|--|--|--|--|
| Date | Revision | Comments | Supersedes | | | | |
| 07/09/2020 | Rev 1 | Initial Release | | | | | |



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